

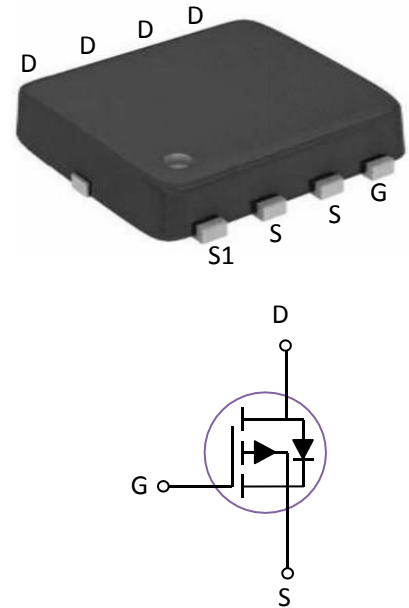
## Description:

This P-Channel MOSFET uses advanced trench technology and design to provide excellent  $R_{DS(on)}$  with low gate charge.

It can be used in a wide variety of applications.

## Features:

- 1)  $V_{DS}=-20V, I_D=-40A, R_{DS(ON)}<9m\ \Omega @V_{GS}=-4.5V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low  $R_{DS(ON)}$ .
- 5) Excellent package for good heat dissipation.



## Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
DOZ40P02	40P02	DFN3*3-8	5000 pcs/Reel

## Absolute Maximum Ratings: ( $T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 12$	V
$I_D$	Continuous Drain Current	-40	A
	Continuous Drain Current- $T_c=100^\circ\text{C}$	-28	
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	-220	
$P_D$	Power Dissipation	42	W
$E_{AS}$	Single pulse avalanche energy <sup>2</sup>	43	mJ
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55-+150	$^\circ\text{C}$

## Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3	$^\circ\text{C}/\text{W}$

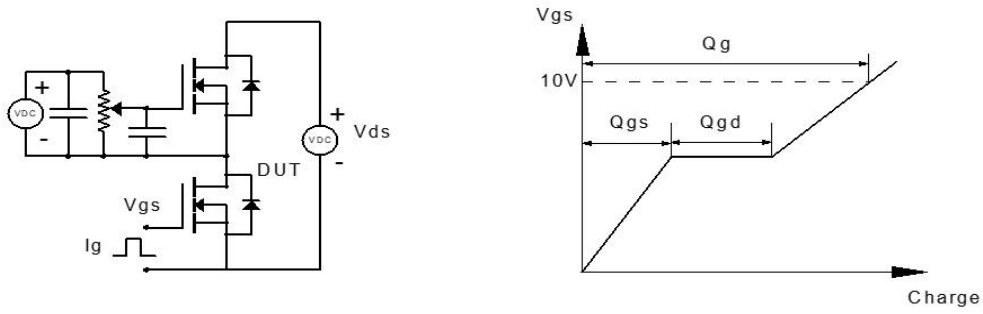
## Electrical Characteristics: ( $T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu A$	-20	---	---	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=-20V$	---	---	-1	$\mu A$
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 12V, V_{DS}=0A$	---	---	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu A$	-0.4	-0.65	-1	V
$R_{DS(ON)}$	Drain-Source On Resistance <sup>3</sup>	$V_{GS}=-4.5V, I_D=-40A$	---	7	9	$m\Omega$
		$V_{GS}=-2.5V, I_D=-40A$	---	9	11	$m\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=-10V, V_{GS}=0V, f=1MHz$	---	2697	---	pF
$C_{oss}$	Output Capacitance		---	308	--	
$C_{rss}$	Reverse Transfer Capacitance		---	270	---	
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=-10V, I_D=-13A,$ $R_{ENG}=2.7\ \Omega, V_{GS}=-10V$	---	12	---	ns
$t_r$	Rise Time		---	104	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	144	---	ns
$t_f$	Fall Time		---	149	---	ns
$Q_g$	Total Gate Charge	$V_{GS}=-4.5V, V_{DS}=-4.5V,$ $I_D=-15A$	---	53	---	nc
$Q_{gs}$	Gate-Source Charge		---	6	---	nc
$Q_{gd}$	Gate-Drain "Miller" Charge		---	13	---	nc
<b>Drain-Source Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage	$V_{GS}=0V, I_{SD}=-10A$	---	---	-1.2	V
$I_S$	Continuous Drain Current	$V_D=V_G=0V$	---	---	-40	A
$I_{SM}$	Pulsed Drain Current		---	---	-220	A

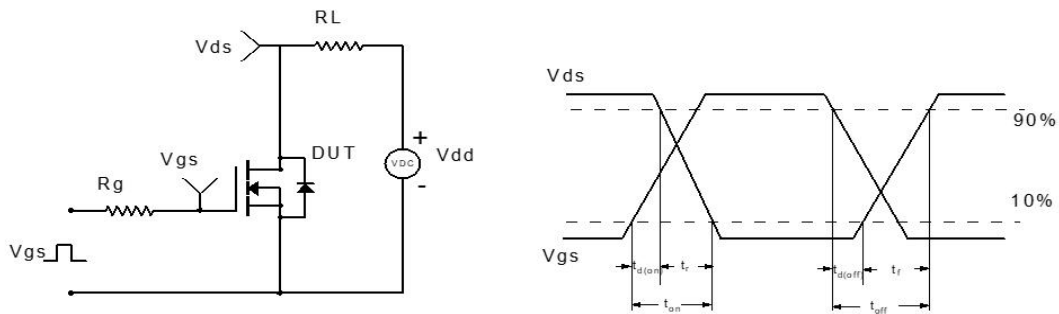
### Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
2.  $E_{AS}$  condition: Starting  $T_J=25^\circ\text{C}$ ,  $V_{DD}=-10V$ ,  $V_G=-10V$ ,  $R_G=25\text{ohm}$ ,  $L=0.5\text{mH}$ ,  $I_{AS}=13A$
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 0.5\%$ .

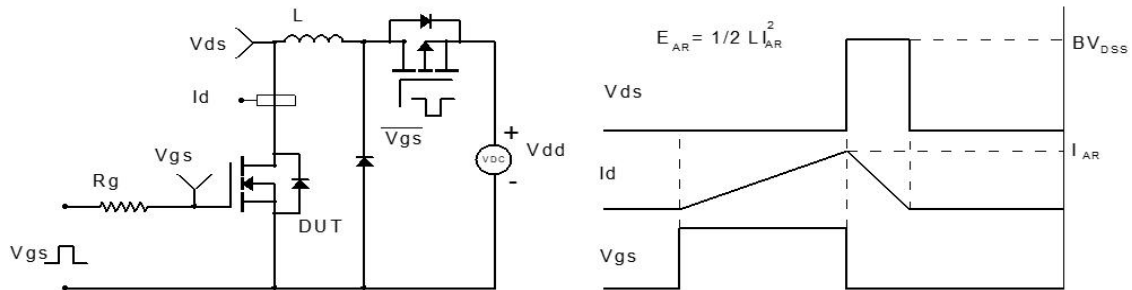
Typical Characteristics: ( $T_c=25^\circ\text{C}$  unless otherwise noted)



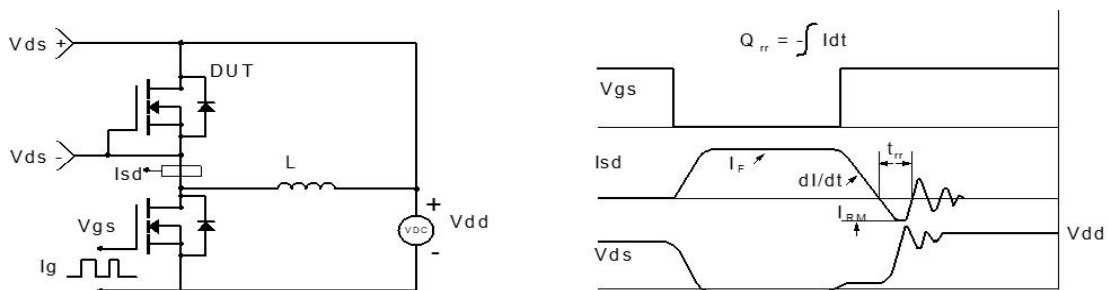
**Figure 1: Gate Charge Test Circuit & Waveform**



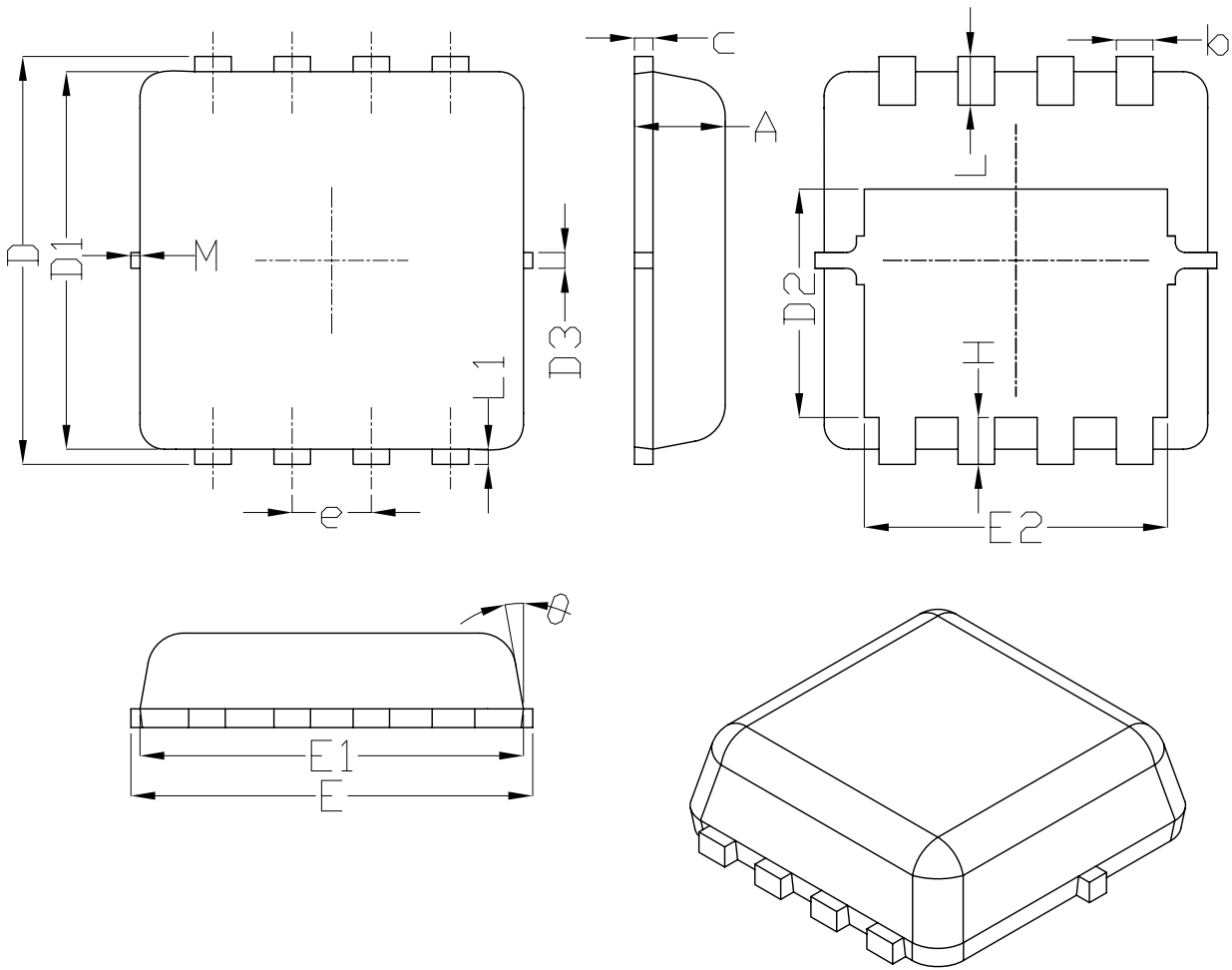
**Figure 2: Resistive Switching Test Circuit & Waveform**



**Figure 3: Unclamped Inductive Switching Test Circuit & Waveform**

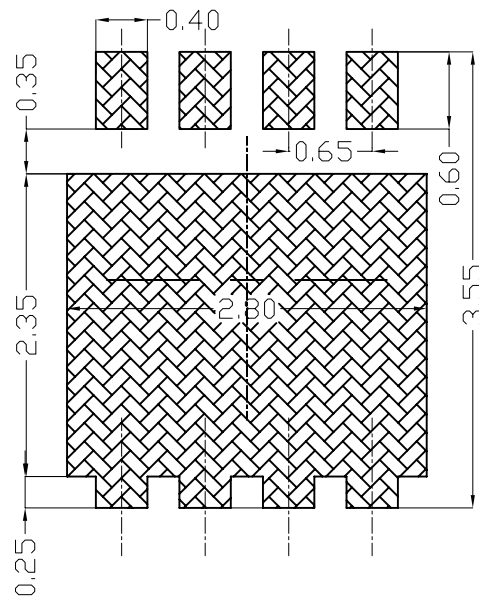


**Figure 4: Diode Recovery Test Circuit & Waveform**

**DFN3X3-8 Package Information:**


SYMBOL	DIMENSIONAL REOMTS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.78	1.88	1.98
D3	---	0.13	---
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
e	0.65BSC		
H	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	---	0.13	---
$\theta$	---	10°	12°
M	*	*	0.15

\* Not specified


**UNIT: mm**

## Marking Information:

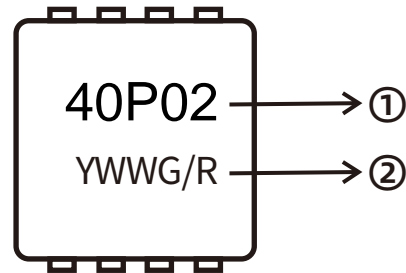
①. Part NO.

②. Date Code(YWWG / R)

Y : Year Code , last digit of the year

WW : Week Code(01-53)


G/R : G(Green) /R(Lead Free)



## Previous Version

Version	Date	Subjects (major changes since last revision)
1.0	2024-06-08	Release of final version

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